Search Notes



Application/Control No.

10622284

Applicant(s)/Patent Under Reexamination

HSU ET AL.

Examiner

Patel, Jayesh A

Art Unit 2624

SEARCHED

Class	Subclass	Date	Examiner
382	236-240	06/15/07	JP
375	240.01,240-29	06/15/0	JP

SE	ΔR	CH	NC)TF	S
\mathbf{v}	\neg ı \setminus	911	110	<i>,</i> , , ,	•

Search Notes	Date	Examiner
Consulted with SPE Jingge Wu regarding the allowance of the	12/13/07	JP
Independent Claims.		

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
382	236-243	12/13/07	JP

U.S. Patent and Trademark Office Part of Paper No.: 20071216